### **Specifications**

		APT-1600FD /	/ APT-1600FD-A	APT-1600FD-SL		
• Test time ( at 2.5mm pitch movement )		Combination test : Max. 0.02 - 0.03sec. / step		Combination test : Max. 0.03 - 0.04sec. / step		
			0.05 - 0.06sec. / step	Single test : Max. 0.07 - 0.08sec. / step		
<ul> <li>Positioning repeatability of flying</li> </ul>	ing probe ( XY )	_	h precision mode, approx.	$\pm 30$ to $\pm 40 \mu m$ in the high precision mode, approx.		
<ul> <li>Minimum pad size for flying pr</li> </ul>			precision mode, approx.	80 to 100µm in the high precision mode, approx.		
				of a roopin in the high precision mode, approx		
General ( all models )						
<ul> <li>Flying probes and sensors</li> </ul>	Top side	Standard type	: 4 tilted contact probes			
		Standard with single vertical Z type		contact probes or 2 IC-open test probes ( changeable )		
		Standard with dual vertical Z type	: 4 tilted contact probes, 2 vertical	contact probes, 2 IC-open test probes		
		LED color test sensors	: 2 sensors ( option )			
	Bottom side	Standard type	: 2 tilted contact probes			
		Standard with single vertical Z type	: 2 tilted contact probes, 2 vertical	contact probes or 2 IC-open test probes (changeable)		
		LED color test sensors	: 2 sensors ( option )			
<ul> <li>Specifications of contact probes</li> </ul>		Type : High precision spring probe, Current rating : 2A, Tip form : Needle, small 4-crown, etc.				
<ul> <li>Motors system for flying probes ( XYZ axes )</li> </ul>		High speed AC servo motors & control system				
<ul> <li>Positioning resolution of flying probes</li> </ul>		X and Y axes : 1.25µm Z axis : 5µm				
<ul> <li>Minimum pad pitch for flying p</li> </ul>	probes	150 to 190 $\mu m$ in use of needle probes (	( high precision mode )			
Test (all models)						
Signal sources for board test		DC Voltage / Current generator -1	· Four-guadrant source & maa	sure system, max. ±20V/±2A <sup>*1</sup>		
g.a. sources for board test		DC Voltage / Current generator -1				
				sure system, max. $\pm 20V/\pm 2A^{*1}$		
		DC Voltage / Current generator -3		sure system, max. ±80V/±1A ( option )		
Monauring ran		AC Constant Voltage generator		Iz to 0.5MHz ( sine, square or triangle wave )		
<ul> <li>Measuring range</li> </ul>		DC Voltage, Current	: ±125V, ±2A <sup>*1</sup> ( max.±40V )			
		AC Voltage	: 150mV to 75Vrms, f = 10Hz			
		Frequency	: 1Hz to 20MHz / 2V to 20Vp-p	)		
		Resistors	: 5mΩ to 50MΩ			
		Capacitors	: 0.5pF to 100F			
		Inductors	: 0.5µH to 500H			
		Impedance / phase angle	: 2.5Ω to 3.3MΩ / ±90°			
		Transformers	: Inductance, detection of wind	ling, transmission ratio		
		Forward voltage of PN junction	: 0.1V to 40V			
		Zener voltage	: 0.1V to 40V ( max.80V, optio	n )		
		Isolation test : Threshold is programmable from 5Ω to 50MΩ				
		Continuity test	: Threshold is programmable fr	rom 1Ω to 500KΩ		
		Diodes / Transistors / FETs	: Forward voltage of PN junction	on, ON test, Gain, Static characteristics		
		Relays / Opti couplers / SW devices	: ON test			
		Open fault detection of IC leads	: Forward voltage measure of I	PN junction, or IC-open test probes		
		Lighting color of LED ( option )		e measured by LED color test sensor		
<ul> <li>Judgment tolerance set</li> </ul>		-999.9% to +999.9% or absolute value				
<ul> <li>Test steps</li> </ul>		Max. 350,000 steps				
lician test system TOC	7E (all models					
/ision test system TOS-	7F (all models	,		· · · · ·		
Video camera		1/3" CCD mega-pixel color digital type,		side )		
Light source		Ring-shaped white LED with 256 levels	5			
<ul> <li>Application</li> </ul>		Coordinates alignment, simple vision te	est, reading of barcode & 2D code, color	real-map, etc.		
<ul> <li>Vision test item</li> </ul>		Non-mounted components, components		r, color inspection of parts, etc.		
<ul> <li>Image registration</li> </ul>		Max. 2,000 scenes ( top and bottom to	otal )			
aser Displacement mea	asurement svst	tem TLS-1				
Light source	and an enterine by St	Red semiconductor laser ( top side )				
Measurement method			ent )			
		Light / reflective type ( laser displacement )				
Laser beam diameter		0.25 x 2.65mm to 0.40 x 2.75mm ( changes by the height of the measurement point )				
Measuring range		-5.0mm to + 50.0mm				
Repeatability		±100µm or less				
<ul> <li>Measuring time</li> </ul>		1ms / point ( XY movement time not included )				
Application		Coordinates alignment by automatic generation of 3D-mapping				
		Non-mounted components, floating components, missing component, etc.				
Jsage environment (all	l models)					
Embedded PC & OS		Windows® PC ( with DVD drive HDD (	or SSD, keyboard, mouse ) OS · Wi	ndows 10 ( 64bit version )		
<ul> <li>Display &amp; Printer</li> </ul>		Windows® PC ( with DVD drive, HDD or SSD, keyboard, mouse )       OS : Windows 10 ( 64bit version )         LCD : 1920 × 1080 resolution       Printer : Small thermal type ( USB connection )				
Power & Air supply						
<ul> <li>Power &amp; Air suppry</li> <li>Operating environment</li> </ul>						
		Competature . 10 to 50 C ( 60 to 86 F )	, mannary . So to 75% ( no conder	nsation ) Altitude : Below 1000m		
Options						
Laser displacement measurement	nt system for bottom	side •LED color test system •DC $\pm 80V/$	±1A programmable source & measuren	nent unit		
Vacuum Unit   CMD Line execut	tion function   NSW t	est function, etc.				
*1 The maximum current can be ap	nnlied by using function	n scanner board ( ontion )				
		e included in specifications as of April, 2022.				
<ul> <li>The technology and the options up</li> </ul>		tion on the part of the manufacturer.	(			
	.ge					
		<b>CORPORTION</b>		Accelonix BV		
* Specifications are subject to change	TAKAYA	CORPORATION		Accelonix BV Luchthavenweg 18b • NL-5657 EB • Eindhoven • The Netherlands •		

## **ULTRAFAST SPEED & HIGH PERFORMANCE** DUAL-SIDE FLYING PROBE TESTER

# **APT-1600FD Series**



The APT-1600FD Series is a dual-sided flying probe test system that deploys the flying probes to both sides of a UUT. Owing to the dual-sided probing contact, the APT-1600FD Series can contribute to a marked increase in test coverage and also assures the shortest amount of test time. In addition, the APT-1600FD Series has world-level advantages in test speed and positioning accuracy and is equipped with a wealth of extraordinary test functionalities, so that your SMT boards can be tested with ease and precision in a short amount of time.

Luchthavenweg 18b • NL-5657 EB • Eindhoven • The Netherlands • : +31 40 750 1650 • E: info@accelonix.n



# **FLYING PROBE TESTER APT-1600FD Series**

#### SAFE AND HIGHLY ACCURATE MEASUREMENT SYSTEM

The APT-1600FD series incorporates 16-bit DC 4-guadrant sources & measurement system and AC programmable generator which is also finding uses as a function generator in the measuring unit so that the tester is capable of applying the best-suited measuring signals according to the specification of each electronic component and the circuit conditions and realizes the circuit test and dynamic characteristics test. Also, the dedicated measuring mode for very small capacitance and the high measuring accuracy circuit give aid to detect a wide range of assembly faults.

#### **ULTRAFAST TEST SPEED !!**

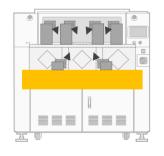
The high power & fast-moving rotary motor system, which has superior performance in practical moving distance, and the new highspeed communication control contribute to speed up test  $30 \sim 50\%$ faster than the conventional models. Also, combination tests performed by using the flying probes on the bottom side make the test time even shorter.

#### ATTENUATING CONTACT PRESSURE OF PROBES

The APT-1600FD series has outstanding ability in controlling the probing speed just before it contacts. This enables to minimize the probing marks on small and sensitive test lands without compromising on test speed.

#### BREAKTHROUGH 4-HEADS & 6-FLYING PROBES ON TOP, 2-HEADS & 4-FLYING PROBES ON BOTTOM

In addition to the standard moving probes which are installed diagonally to the UUT, vertical Z-axis units (option) where either probe or IC-open test probe can move up and down vertically are also available on both top side and bottom side. The vertical Z-axis units enable to get access to the test points where are hard for the standard flying probes. Besides, it's possible to directly contact the through-holes and the head of connector pins by using different types of probes, resulting in increased test coverage.



#### HIGH ACCURACY ENSURED BY RIGID XY STAGE

The tester's XY stage, crucial to stable and accurate probe contact, is made of highly polished native granite, as well as the APT-9xxx series which is thought of as the global standard model of the flying probe testers. Also, the positioning accuracy is finely tuned tester by tester. Therefore, the APT-1600FD series ensures superfast probe movement and increased positioning accuracy by 25% compared to the conventional models.

#### TEST ABILITY IN A CONSTANT STATE OF EVOLUTION

The APT-1600FD series serves its customers with versatile option boards and software that achieves their particular needs, such as the LED color test system that measures hue, saturation and luminance of LED devices on the board under test, the component height test based on laser ranging, the Boundary testing, and the Functional testing. Also, the tester will have even more advantages to enhance its test coverage and speed up test although they are currently under development.



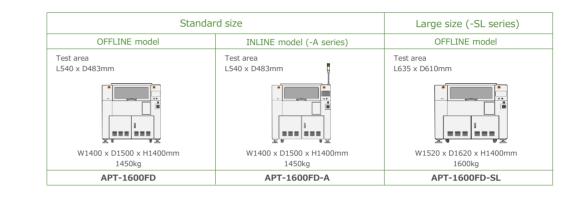


#### COLORED VISION SYSTEM AND REAL MAP

The APT-1600FD series is equipped with new vision test system TOS-7F corresponding to color images as standard on both top and bottom side. Owing to the megapixel color digital camera and the ring illuminations with high-intensity white LED, the TOS-7F can import sharp color image to detect missing, wrong orientation and positioning error on the spot. Besides, the TOS-7F can not only read the barcodes (including 2D codes) but also offer color identification test and Library function which are supported by the optional software. Also, the APT-1600FD series is equipped with the colored Real map function which is of remarkable help to check and modify the contact points during debugging the programs.

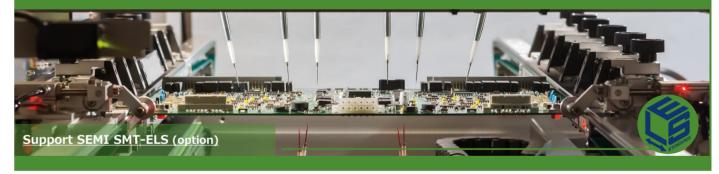
#### LARGER TEST AREA & AUTO TRANSFER

The "-SL" series, which provides 48% larger test area, and the "-A" series, which enables to transfer UUT automatically, are also available for selection to fit user needs.



#### AUTOMATED CONVEYOR SYSTEM

An automated conveyor system model can be built-to-order to establish a fully automated operation in your production line or rack-to-rack system. To meet various user's needs, it's possible to provide a buffer station with conveyor installed to cut down transport time as much as possible and an auto-conveyor width adjustment unit, as well as a shutter unit that operates when the conveyor carries a PCB in and out.



#### **Board specifications**

	APT-1600FD	APT-1600FD-A	APT-1600FD-SL			
• Board size (min.)	L50 x D50mm					
Board size (max.)	L540 x D483mm	L540 x D483mm / L890 x D483mm*2	L635 x D610mm			
Board Thickness	0.6mm to 5.0mm					
	Top side 60mm					
Component height (max.)	Bottom side 60mm					
Component-free area	3mm or more from front and rear edges ( for board clamp)					
• Board weight (max.)	5kg	3kg	8kg or 15kg <sup>*3</sup>			

#### Automated conveyor specifications (Inline model only)

• Transfer speed and belt ( Speed selectable )		200 to 667mm/sec. ( 6 ranges ) Timing belt ( anti-static type )			
• Transfer direction / height	Direction selectable, FL 900mm ( -15/+65mm )				
Conveyor width adjustment	Front side - fixed, Rear side - auto-adjustment with correction mechanism of parallelism				
Interface for loader / unloader	SMEMA standard or SEMI SMT-ELS standard (option)				
• Operation panel / Tower light	4.3" colors TFT touch LCD / Colors lamp ( red / green / yellow ) with buzzer				

\*2 Divided PCB test function is required.

\*3 Customized clamper with specific air is required

